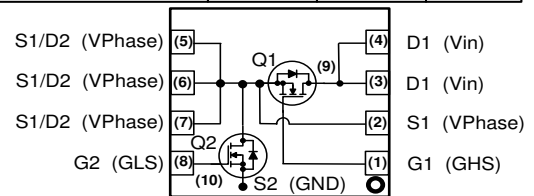


**Power Block**
**Features**

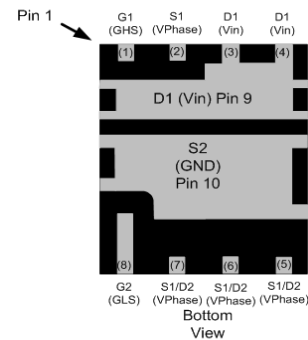
- Dual asymmetric N-channel OptiMOS™5 MOSFET
- Logic level (4.5V rated)
- Pb-free lead plating; RoHS compliant
- Optimized for high performance Buck converter
- Qualified according to JEDEC<sup>1)</sup> for target applications
- Halogen-free according to IEC61249-2-21
- Monolithic integrated Schottky like diode

**Product Summary**

|                  |                       | Q1 | Q2   |    |
|------------------|-----------------------|----|------|----|
| $V_{DS}$         |                       | 25 | 25   | V  |
| $R_{DS(on),max}$ | $V_{GS}=10\text{ V}$  | 3  | 0.85 | mΩ |
|                  | $V_{GS}=4.5\text{ V}$ | 4  | 1.2  |    |
| $I_D$            |                       | 50 | 50   | A  |



Top view



Bottom View



| Type       | Package     | Marking |
|------------|-------------|---------|
| BSG0810NDI | PG-TISON8-4 | 0810NDI |

**Maximum ratings, at  $T_j=25^\circ\text{C}$ , unless otherwise specified <sup>2)</sup>**

| Parameter                           | Symbol         | Conditions  | Value       |      | Unit             |
|-------------------------------------|----------------|---|-------------|------|------------------|
|                                     |                |   | Q1          | Q2   |                  |
| Continuous drain current            | $I_D$          | $T_C=70^\circ\text{C}$ , $V_{GS}=10\text{ V}$                             | 50          | 50   | A                |
|                                     |                | $T_C=70^\circ\text{C}$ , $V_{GS}=4.5\text{ V}$                            | 50          | 50   |                  |
|                                     |                | $T_A=25^\circ\text{C}$ ,<br>$V_{GS}=4.5\text{ V}^{3)}$                    | 31          | 50   |                  |
|                                     |                | $T_A=25^\circ\text{C}$ ,<br>$V_{GS}=4.5\text{ V}^{4)}$                    | 19          | 39   |                  |
| Pulsed drain current                | $I_{D,pulse}$  | $T_C=70^\circ\text{C}$  | 160         | 160  |                  |
| Avalanche energy, single pulse      | $E_{AS}$       | Q1: $I_D=10\text{ A}$ ,<br>Q2: $I_D=20\text{ A}$ ,<br>$R_{GS}=25\ \Omega$ | 30          | 90   | mJ               |
| Gate source voltage                 | $V_{GS}$       | $T_j=25^\circ\text{C}$  | $\pm 16$    |      | V                |
| Power dissipation                   | $P_{tot}$      | $T_A=25^\circ\text{C}^{3)}$   | 6.25        | 6.25 | W                |
|                                     |                | $T_A=25^\circ\text{C}^{4)}$   | 2.5         | 2.5  |                  |
| Operating and storage temperature   | $T_j, T_{stg}$ |   | -55 ... 150 |      | $^\circ\text{C}$ |
| IEC climatic category; DIN IEC 68-1 |                |   | 55/150/56   |      |                  |

<sup>1)</sup> J-STD20 and JESD22

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Thermal characteristics**

|  |    |  |  |   |    |     |     |
|--|----|--|--|---|----|-----|-----|
| Thermal resistance, junction - case                  | Q1 | $R_{thJC}$                                   |  | - | -  | 4.3 | K/W |
|  | Q2 |  |  | - | -  | 1.8 |     |
| Thermal resistance, junction - ambient <sup>2)</sup> | Q1 | $R_{thJA}$                                   | Application specific board <sup>3)</sup> | - | -  | 20  |     |
|  | Q2 |  |  |   |    |     |     |
|  | Q1 | 6 cm <sup>2</sup> cooling area <sup>4)</sup> | -  | - | 50 |     |     |
|  | Q2 |  |  |   |    |     |     |

**Electrical characteristics, at  $T_j=25\text{ °C}$ , unless otherwise specified**
**Static characteristics**

|   |    |                     |  |                  |     |     |               |
|---|----|---------------------|--|------------------|-----|-----|---------------|
| Drain-source breakdown voltage            | Q1 | $V_{(BR)DSS}$       | $V_{GS}=0\text{ V}, I_D=1\text{ mA}$                       | 25 <sup>6)</sup> | -   | -   | V             |
|   | Q2 |                     |  |                  |     |     |               |
| Breakdown voltage temperature coefficient | Q1 | $dV_{(BR)DSS}/dT_j$ | $I_D=10\text{ mA}$ , referenced to 25 °C                   | -                | 15  | -   | mV/K          |
|   | Q2 |                     |  |                  |     |     |               |
| Gate threshold voltage                    | Q1 | $V_{GS(th)}$        | $V_{DS}=V_{GS}, I_D=250\text{ }\mu\text{A}$                | 1.2              | 1.6 | 2   | V             |
|   | Q2 |                     |  |                  |     |     |               |
| Zero gate voltage drain current           | Q1 | $I_{DSS}$           | $V_{DS}=25\text{ V}, V_{GS}=0\text{ V}, T_j=25\text{ °C}$  | -                | -   | 1   | $\mu\text{A}$ |
|   | Q2 |                     |  |                  |     | 500 |               |
|   | Q1 |                     | $V_{DS}=20\text{ V}, V_{GS}=0\text{ V}, T_j=125\text{ °C}$ | -                | 3   | 100 | mA            |
|   | Q2 |                     |  |                  |     | -   |               |
| Gate-source leakage current               | Q1 | $I_{GSS}$           | $V_{GS}=16\text{ V}, V_{DS}=0\text{ V}$                    | -                | -   | 100 | nA            |
|   | Q2 |                     |  |                  |     |     |               |
| Drain-source on-state resistance          | Q1 | $R_{DS(on)}$        | $V_{GS}=4.5\text{ V}, I_D=20\text{ A}$                     | -                | 3.2 | 4.0 | m $\Omega$    |
|   | Q2 |                     |  |                  |     | 1.1 |               |
|   | Q1 |                     | $V_{GS}=10\text{ V}, I_D=20\text{ A}$                      | -                | 0.7 | 2.4 | 0.9           |
|   | Q2 |                     |  |                  |     | 0.9 |               |
| Gate resistance                           | Q1 | $R_G$               |  | -                | 0.7 | 1.2 | $\Omega$      |
|   | Q2 |                     |  |                  |     | 1.3 |               |
| Transconductance                          | Q1 | $g_{fs}$            | $ V_{DS} >2 I_D R_{DS(on)max}, I_D=20\text{ A}$            | 47               | 94  | -   | S             |
|   | Q2 |                     |  |                  |     | 55  |               |

<sup>2)</sup> Remark: only one of both transistors active

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

**Dynamic characteristics**

|                              |    |              |  |   |      |      |    |
|------------------------------|----|--------------|--|---|------|------|----|
| Input capacitance            | Q1 | $C_{iss}$    | $V_{GS}=0\text{ V},$<br>$V_{DS}=12\text{ V}, f=1\text{ MHz}$   | - | 770  | 1040 | pF |
|                              | Q2 |              |  | - | 2300 | 3100 |    |
| Output capacitance           | Q1 | $C_{oss}$    |  | - | 390  | 520  |    |
|                              | Q2 |              |  | - | 1400 | 1900 |    |
| Reverse transfer capacitance | Q1 | $C_{rss}$    |  | - | 33   | -    |    |
|                              | Q2 |              |  | - | 110  | -    |    |
| Turn-on delay time           | Q1 | $t_{d(on)}$  | $V_{IN}=12\text{ V},$<br>$V_{DRV}=5\text{ V},$<br>$F_{SW}=500\text{ KHz},$<br>$I_{OUT}=30\text{ A}^5)$ | - | 4.3  | -    | ns |
|                              | Q2 |              |  | - | 5.1  | -    |    |
| Rise time                    | Q1 | $t_r$        |  | - | 4.7  | -    |    |
|                              | Q2 |              |  | - | 4.0  | -    |    |
| Turn-off delay time          | Q1 | $t_{d(off)}$ |  | - | 4.3  | -    |    |
|                              | Q2 |              |  | - | 8    | -    |    |
| Fall time                    | Q1 | $t_f$        |  | - | 1.4  | -    |    |
|                              | Q2 |              |  | - | 2.4  | -    |    |

**Gate Charge Characteristics**

|                       |    |               |  |  |     |     |    |    |
|-----------------------|----|---------------|--|--|-----|-----|----|----|
| Gate to source charge | Q1 | $Q_{gs}$      | $V_{DD}=12\text{ V},$<br>$I_D=20\text{ A},$<br>$V_{GS}=0\text{ to }4.5\text{ V}$ | -  | 2.2 | -   | nC |    |
| Gate to drain charge  |    | $Q_{gd}$      |  | -  | 1.6 | -   |    |    |
| Gate charge total     |    | $Q_g$         |  | -  | 5.6 | 8.4 |    |    |
| Gate plateau voltage  |    | $V_{plateau}$ |  | -  | 2.9 | -   |    | V  |
| Gate to source charge | Q2 | $Q_{gs}$      |  | $V_{DD}=12\text{ V},$<br>$I_D=20\text{ A},$<br>$V_{GS}=0\text{ to }4.5\text{ V}$ | -   | 5.9 | -  | nC |
| Gate to drain charge  |    | $Q_{gd}$      |  |  | -   | 4.2 | -  |    |
| Gate charge total     |    | $Q_g$         |  |  | -   | 16  | 25 |    |
| Gate plateau voltage  |    | $V_{plateau}$ |  |  | -   | 2.6 | -  |    |
| Output charge         | Q1 | $Q_{oss}$     | $V_{DD}=12\text{ V}, V_{GS}=0\text{ V}$  |  | -   | 8   | -  | nC |
|                       | Q2 |               |  |  | -   | 26  | -  |    |

<sup>3)</sup> 8 Layers copper 70µm thickness. PCB in still air

<sup>4)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

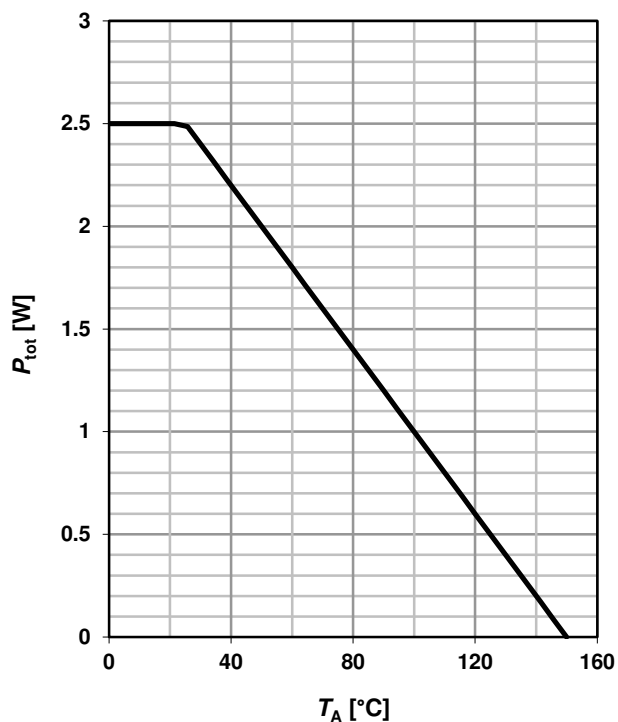
| Parameter                        | Symbol | Conditions    | Values  |      |      | Unit |    |
|----------------------------------|--------|---------------|---|------|------|------|----|
|                                  |        |               | min.  | typ. | max. |      |    |
| <b>Reverse Diode</b>             |        |               |   |      |      |      |    |
| Diode continuous forward current | Q1     | $I_S$         | $T_C=25\text{ °C}$  | -    | -    | 29   | A  |
|                                  | Q2     |               |   |      |      | 50   |    |
| Diode pulse current              | Q1     | $I_{S,pulse}$ | $T_C=25\text{ °C}$  | -    | -    | 160  |    |
|                                  | Q2     |               |   | -    | -    | 160  |    |
| Diode forward voltage            | Q1     | $V_{SD}$      | $V_{GS}=0\text{ V}, I_F=20\text{ A},$<br>$T_j=25\text{ °C}$       | -    | 0.85 | 1    | V  |
|                                  | Q2     |               | $V_{GS}=0\text{ V}, I_F=11\text{ A},$<br>$T_j=25\text{ °C}$       | -    | 0.49 | 0.7  |    |
| Reverse recovery charge          | Q1     | $Q_{rr}$      | $V_R=12\text{ V}, I_F=I_S,$<br>$di_F/dt=100\text{ A}/\mu\text{s}$ | -    | 10   | -    | nC |
|                                  | Q2     |               |   |      |      |      |    |

<sup>5)</sup> For more information see application note n° TBD

<sup>6)</sup> The device can withstand a pulse of not more than 30V for a duration of up to 2ns at a frequency of 600KHz with maximum buck converter input voltage  $V_{IN}=16\text{ V}$

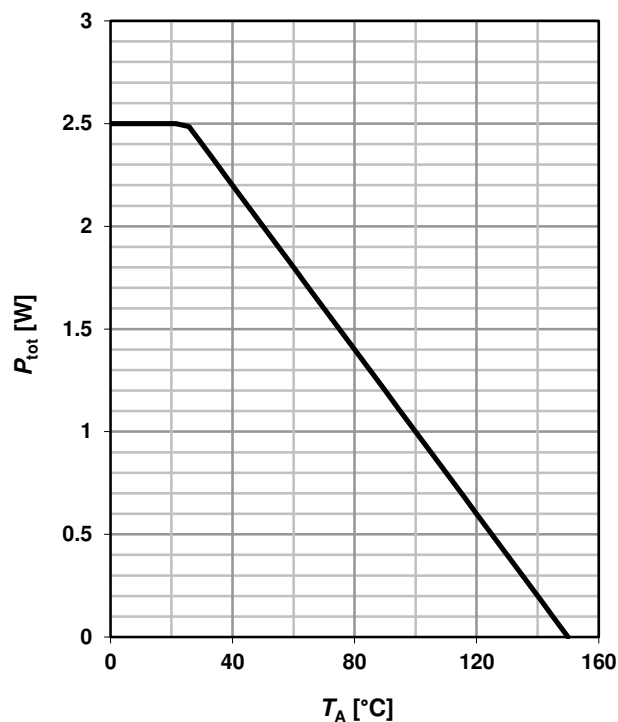
**1 Power dissipation (Q1)**

$$P_{tot}=f(T_A)^4$$



**2 Power dissipation (Q2)**

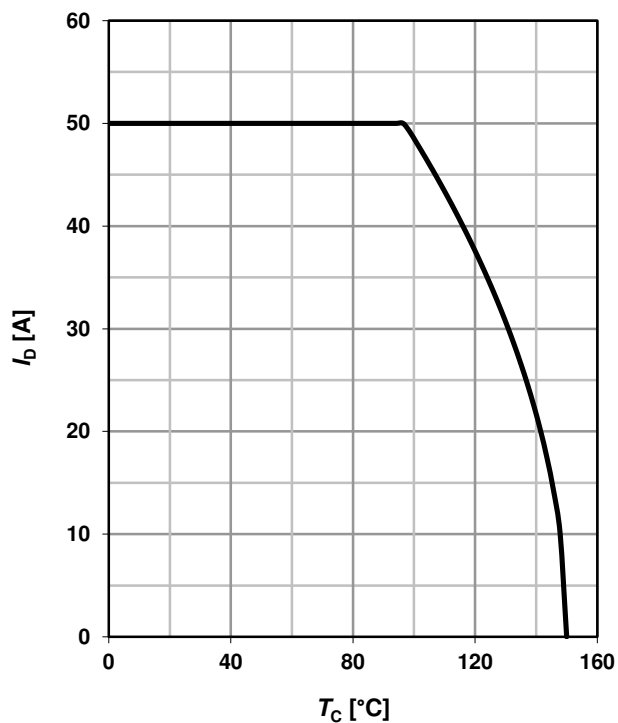
$$P_{tot}=f(T_A)^4$$



**3 Drain current (Q1)**

$$I_D=f(T_C)$$

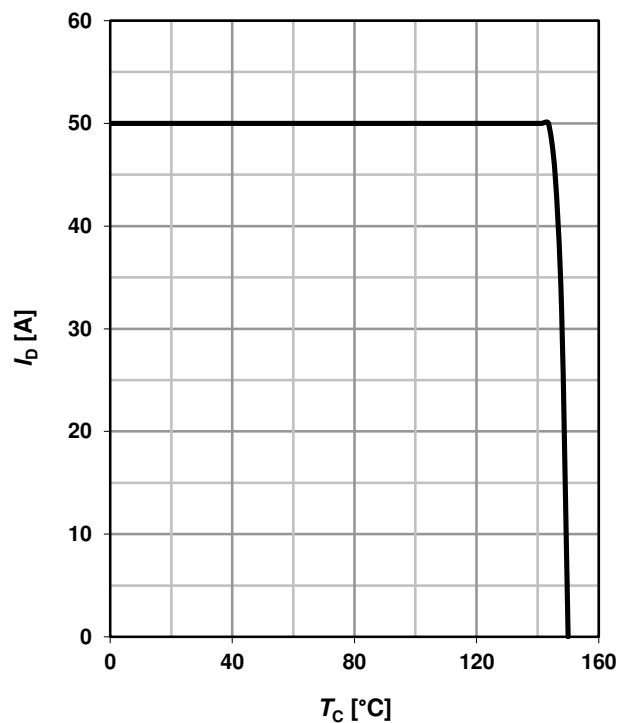
parameter:  $V_{GS} \geq 10$  V



**4 Drain current (Q2)**

$$I_D=f(T_C)$$

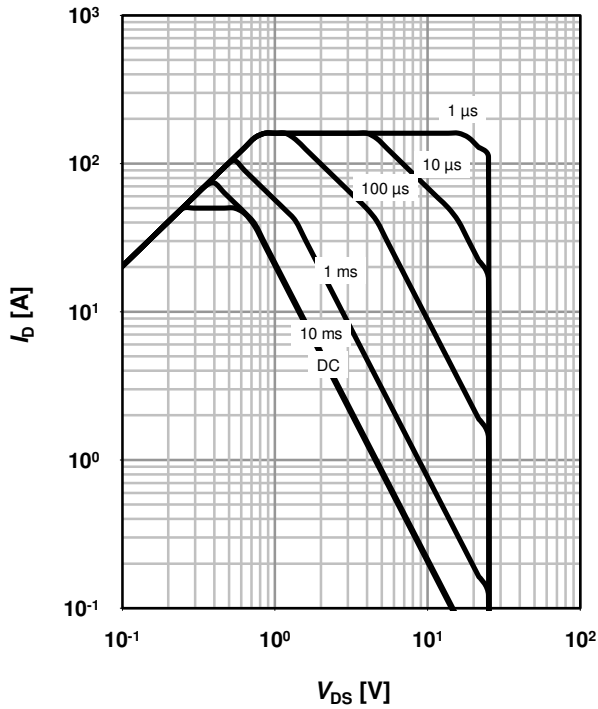
parameter:  $V_{GS} \geq 10$  V



**5 Safe operating area (Q1)**

$I_D=f(V_{DS}); T_C=25\text{ }^\circ\text{C}; D=0$

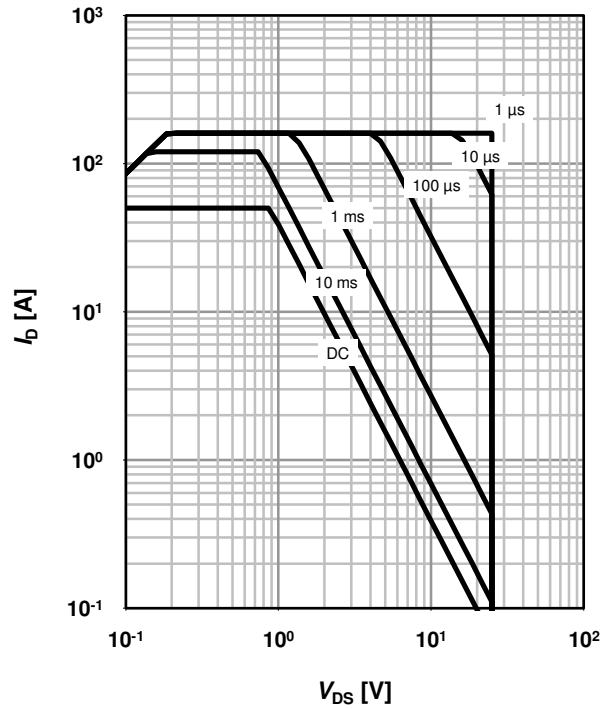
parameter:  $t_p$



**6 Safe operating area (Q2)**

$I_D=f(V_{DS}); T_C=25\text{ }^\circ\text{C}; D=0$

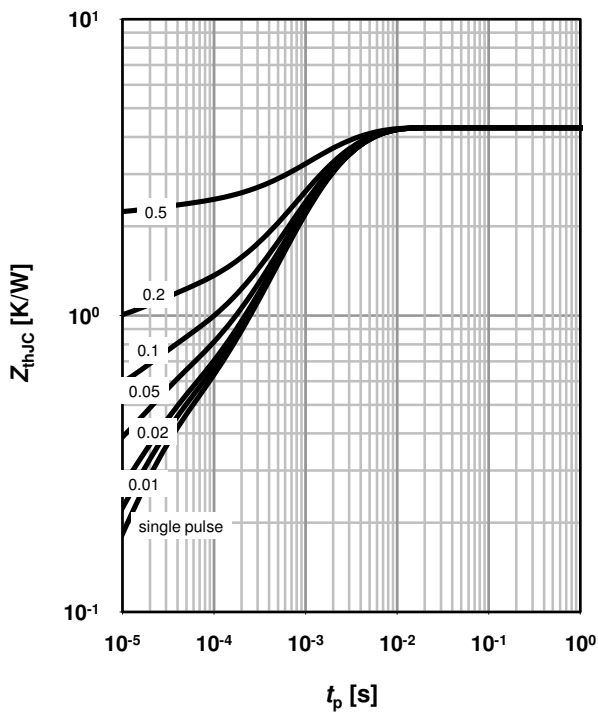
parameter:  $t_p$



**7 Max. transient thermal impedance (Q1)**

$Z_{thJC}=f(t_p)$

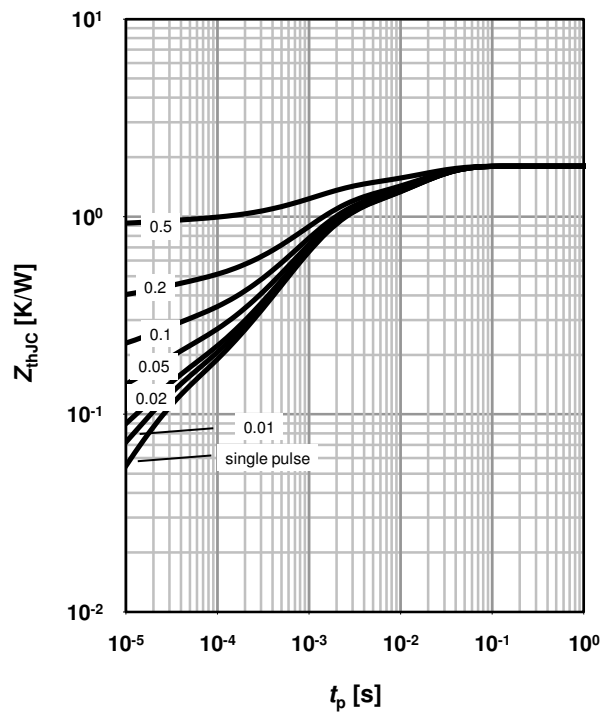
parameter:  $D=t_p/T$



**8 Max. transient thermal impedance (Q2)**

$Z_{thJC}=f(t_p)$

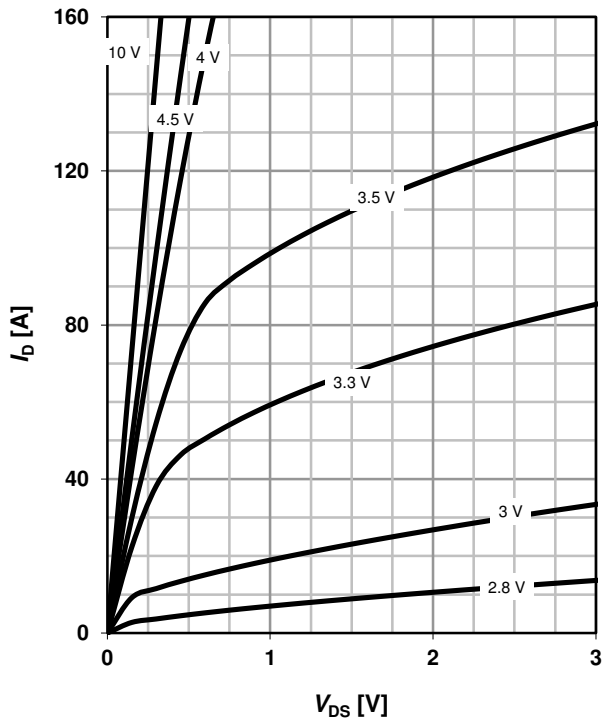
parameter:  $D=t_p/T$



**9 Typ. output characteristics (Q1)**

$I_D=f(V_{DS}); T_j=25\text{ }^\circ\text{C}$

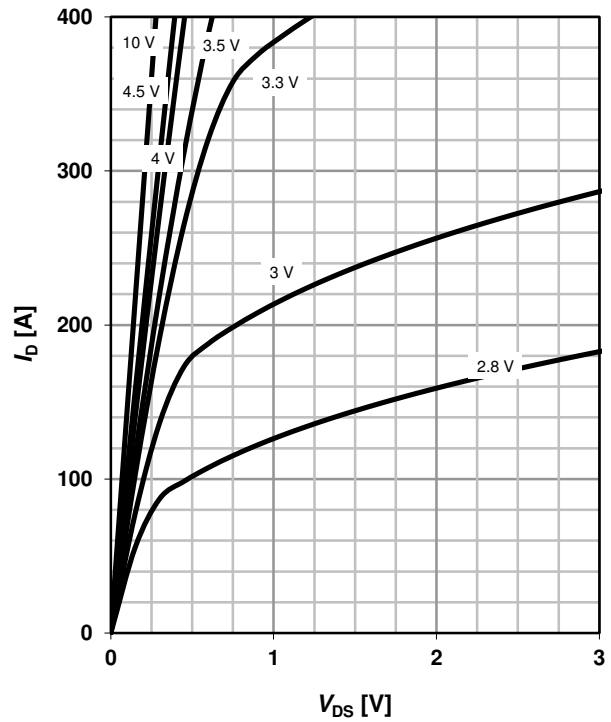
parameter:  $V_{GS}$



**10 Typ. output characteristics (Q2)**

$I_D=f(V_{DS}); T_j=25\text{ }^\circ\text{C}$

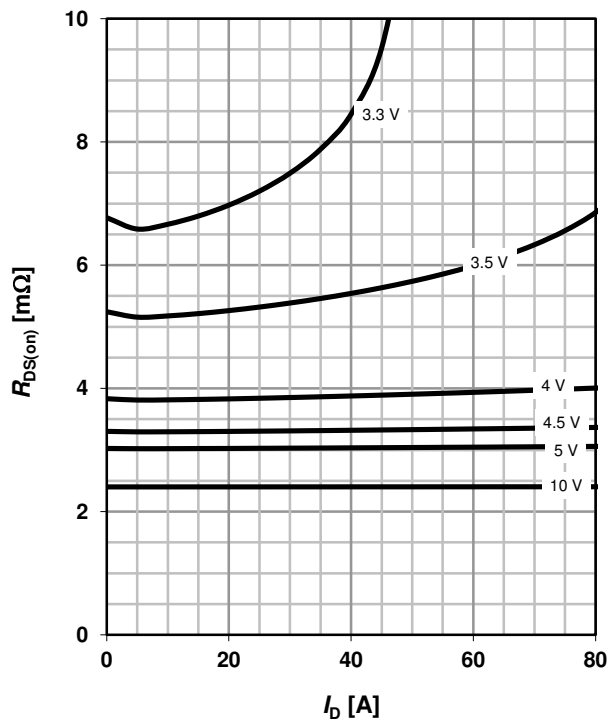
parameter:  $V_{GS}$



**11 Typ. drain-source on resistance (Q1)**

$R_{DS(on)}=f(I_D); T_j=25\text{ }^\circ\text{C}$

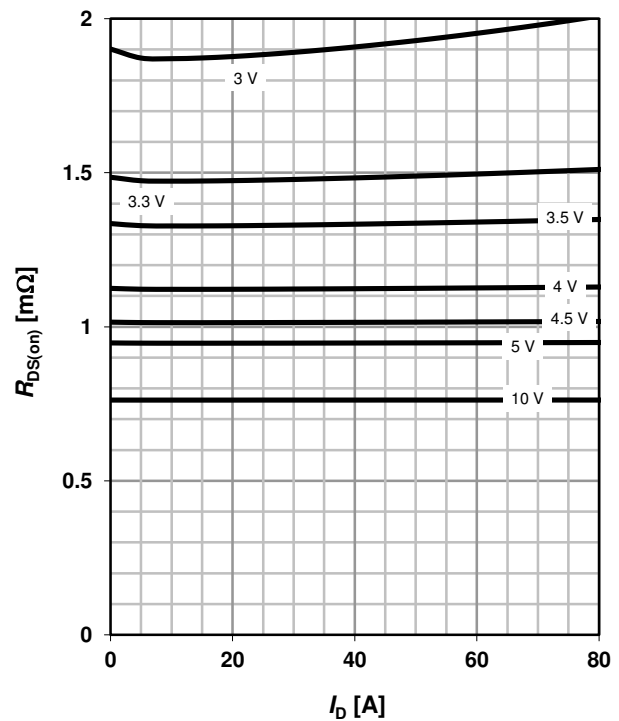
parameter:  $V_{GS}$



**12 Typ. drain-source on resistance (Q2)**

$R_{DS(on)}=f(I_D); T_j=25\text{ }^\circ\text{C}$

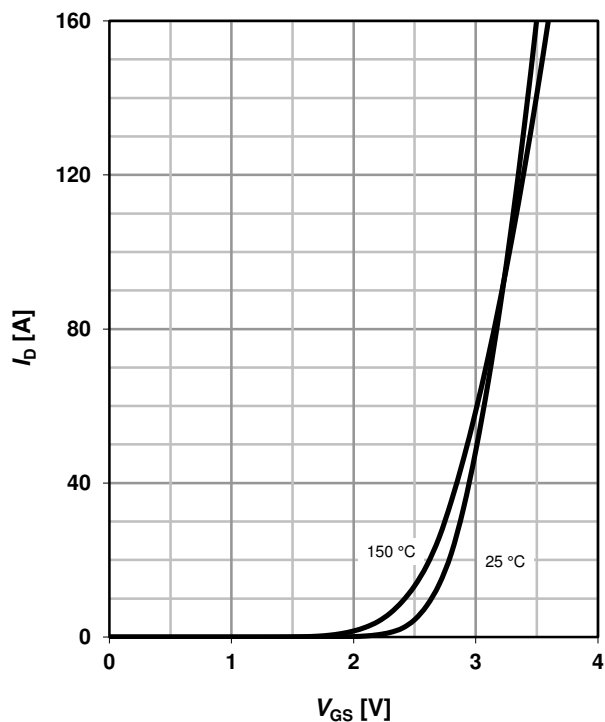
parameter:  $V_{GS}$



**13 Typ. transfer characteristics (Q1)**

$$I_D = f(V_{GS}); |V_{DS}| > 2 |I_D| R_{DS(on)max}$$

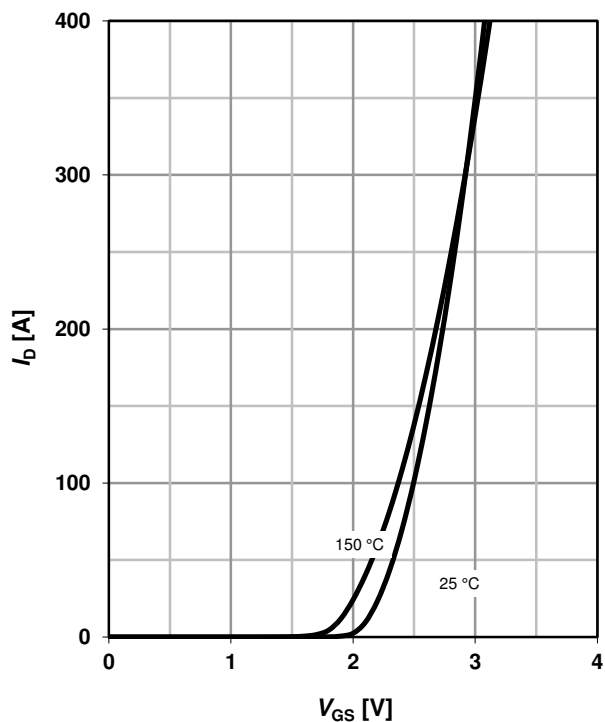
parameter:  $T_j$



**14 Typ. transfer characteristics (Q2)**

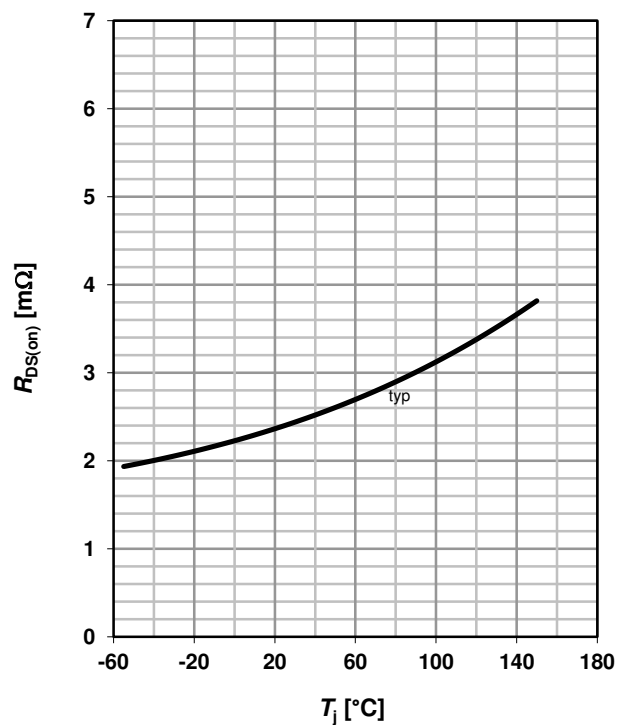
$$I_D = f(V_{GS}); |V_{DS}| > 2 |I_D| R_{DS(on)max}$$

parameter:  $T_j$



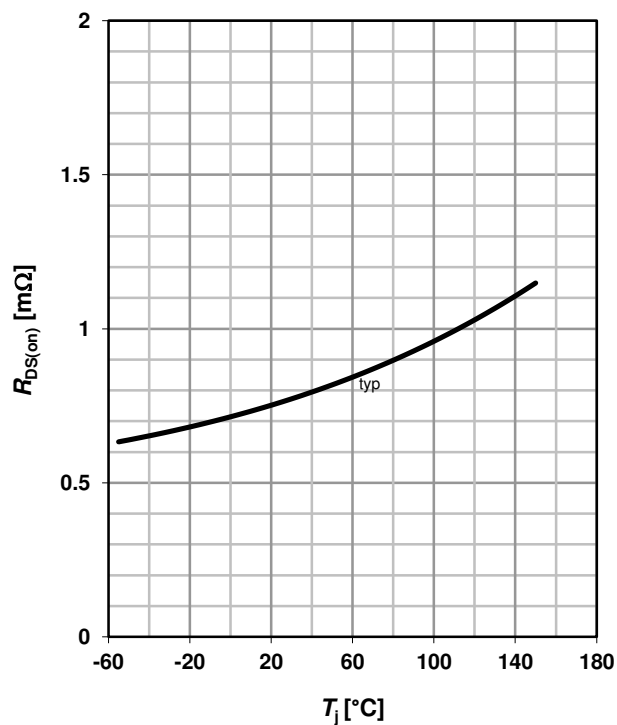
**15 Drain-source on-state resistance (Q1)**

$$R_{DS(on)} = f(T_j); I_D = 20 \text{ A}; V_{GS} = 10 \text{ V}$$



**16 Drain-source on-state resistance (Q2)**

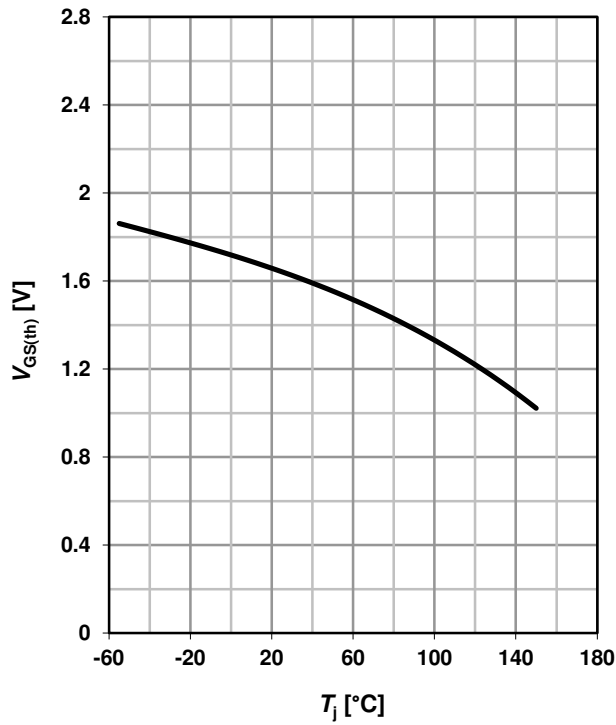
$$R_{DS(on)} = f(T_j); I_D = 20 \text{ A}; V_{GS} = 10 \text{ V}$$





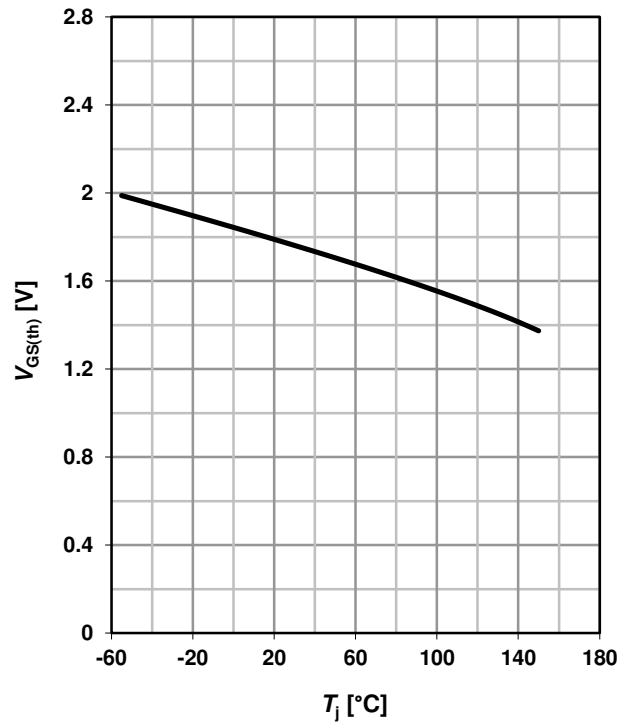
**17 Typ. gate threshold voltage (Q1)**

$V_{GS(th)}=f(T_j)$ ;  $V_{GS}=V_{DS}$ ;  $I_D=250 \mu A$



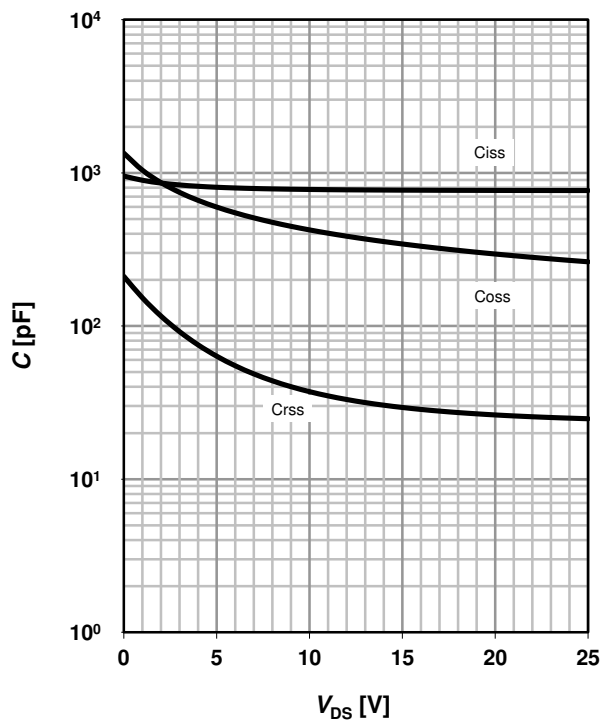
**18 Typ. gate threshold voltage (Q2)**

$V_{GS(th)}=f(T_j)$ ;  $V_{GS}=V_{DS}$ ;  $I_D=10 \text{ mA}$



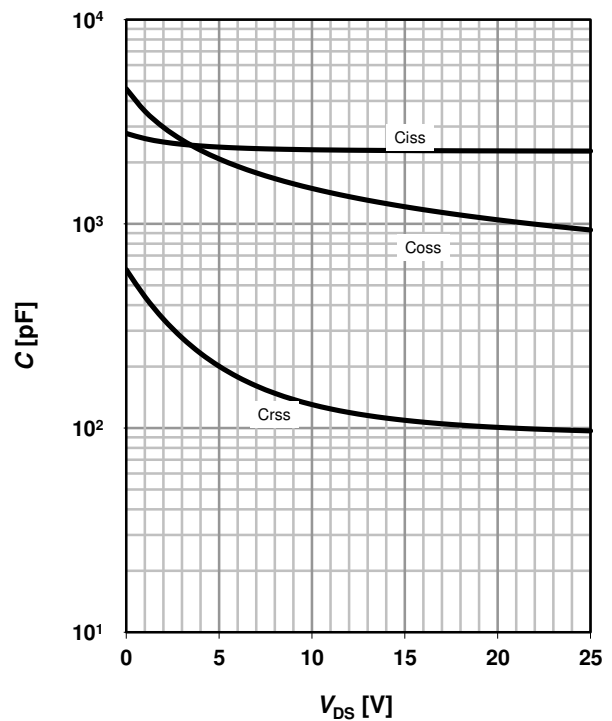
**19 Typ. capacitances (Q1)**

$C=f(V_{DS})$ ;  $V_{GS}=0 \text{ V}$ ;  $f=1 \text{ MHz}$



**20 Typ. capacitances (Q2)**

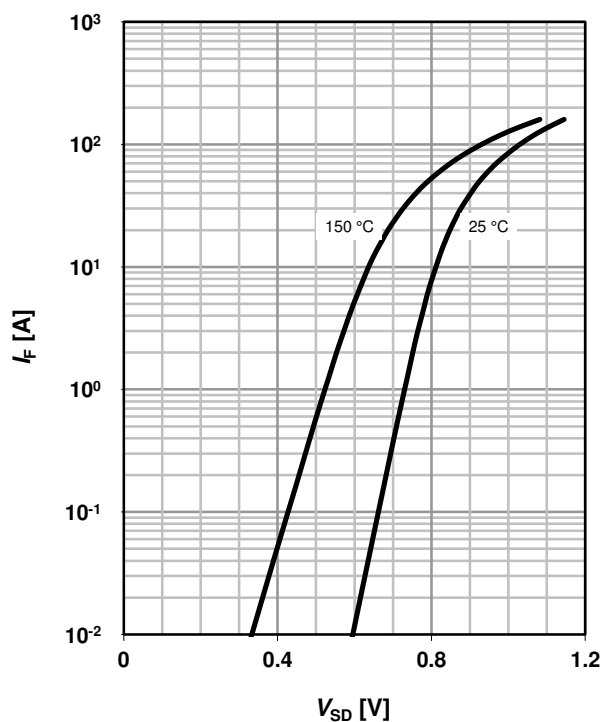
$C=f(V_{DS})$ ;  $V_{GS}=0 \text{ V}$ ;  $f=1 \text{ MHz}$



**21 Forward characteristics of reverse diode (Q1)**

$I_F=f(V_{SD})$

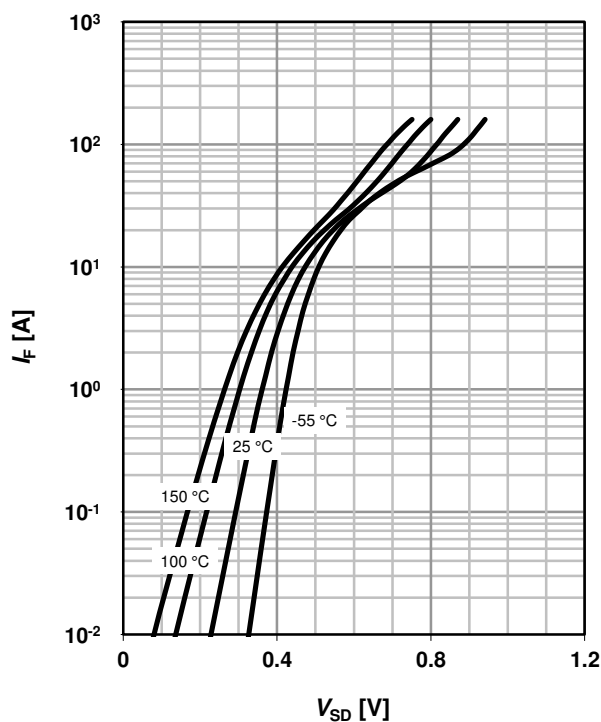
parameter:  $T_j$



**22 Forward characteristics of reverse diode (Q2)**

$I_F=f(V_{SD})$

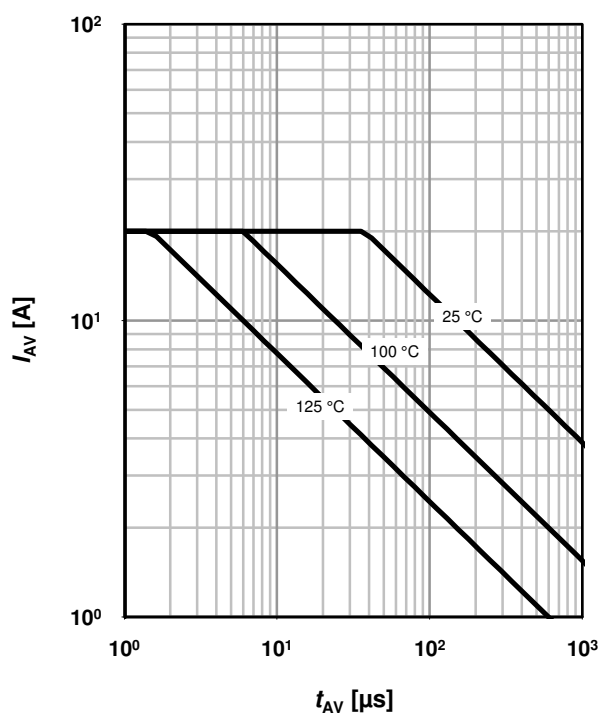
parameter:  $T_j$



**23 Avalanche characteristics (Q1)**

$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

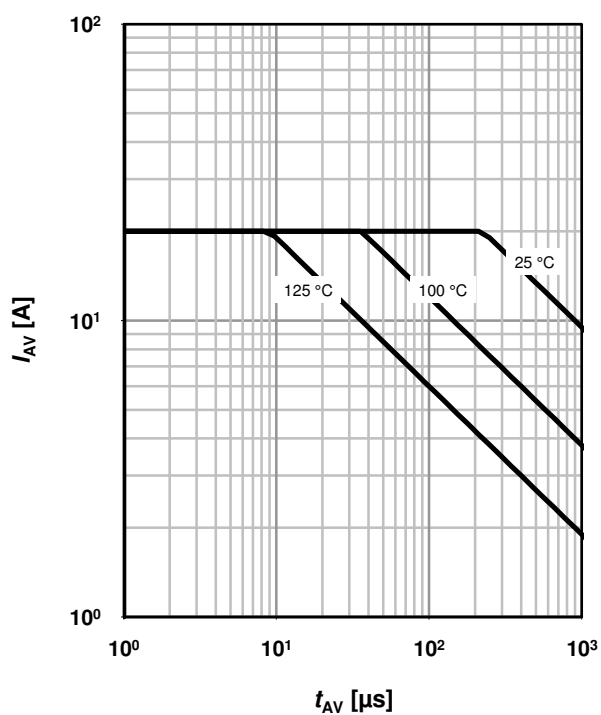
parameter:  $T_{j(start)}$



**24 Avalanche characteristics (Q2)**

$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$

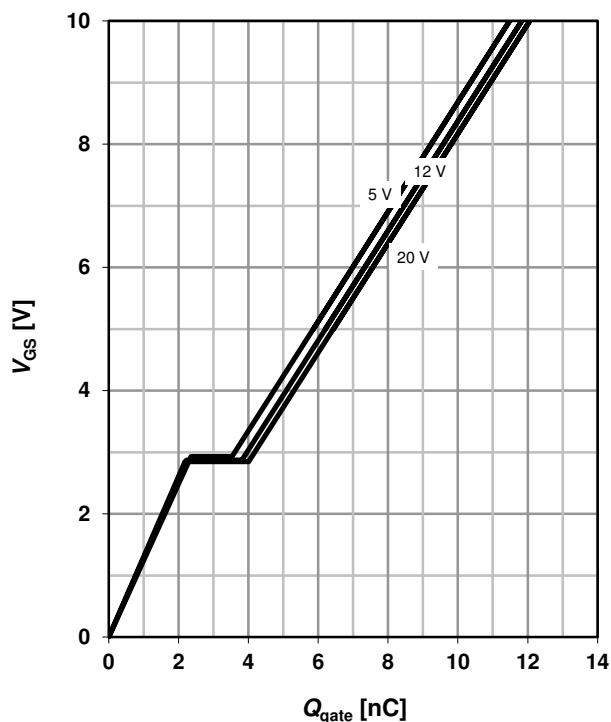
parameter:  $T_{j(start)}$



**25 Typ. gate charge (Q1)**

$V_{GS}=f(Q_{gate}); I_D=20\text{ A pulsed}$

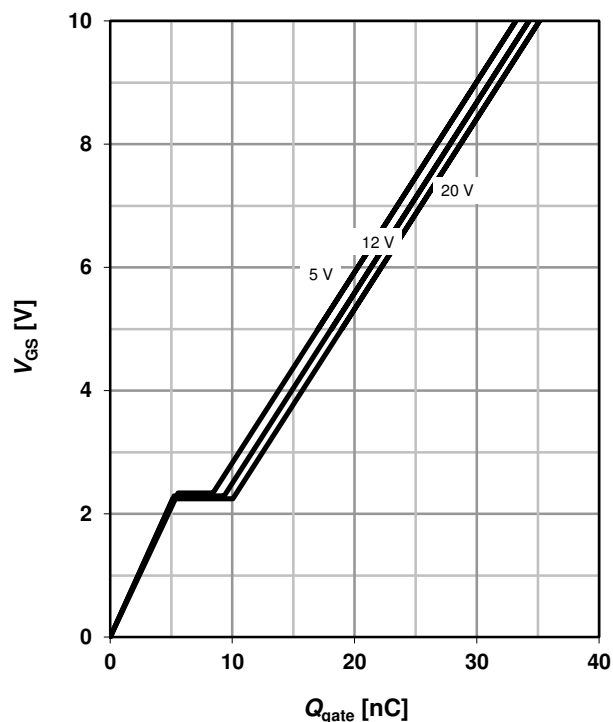
parameter:  $V_{DD}$



**26 Typ. gate charge (Q2)**

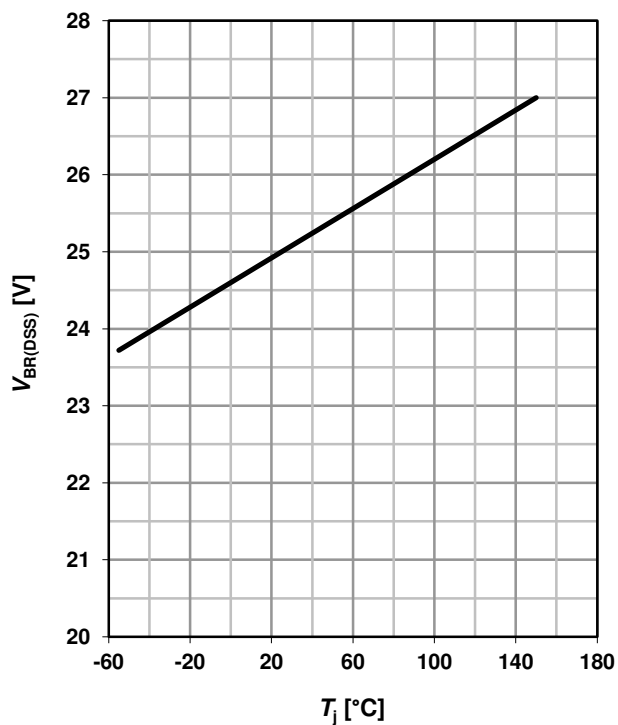
$V_{GS}=f(Q_{gate}); I_D=20\text{ A pulsed}$

parameter:  $V_{DD}$



**27 Drain-source breakdown voltage (Q1)**

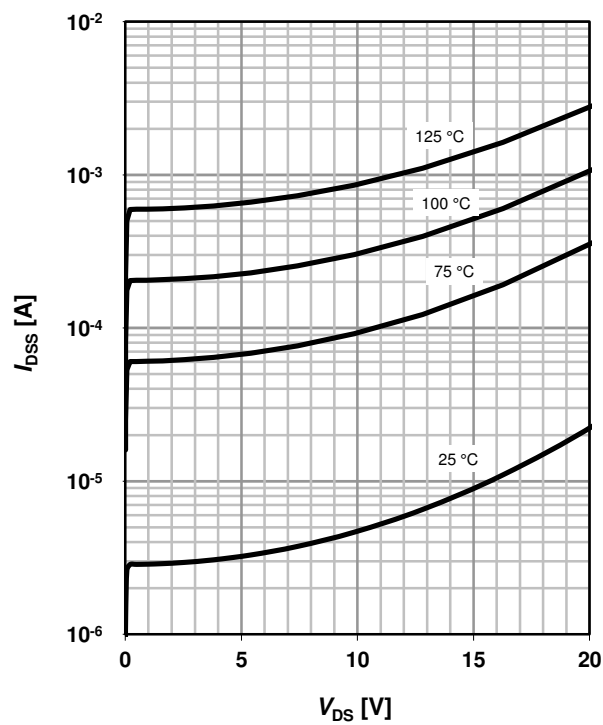
$V_{BR(DSS)}=f(T_j); I_D=1\text{ mA}$



**28 Typ. drain-source leakage current (Q2)**

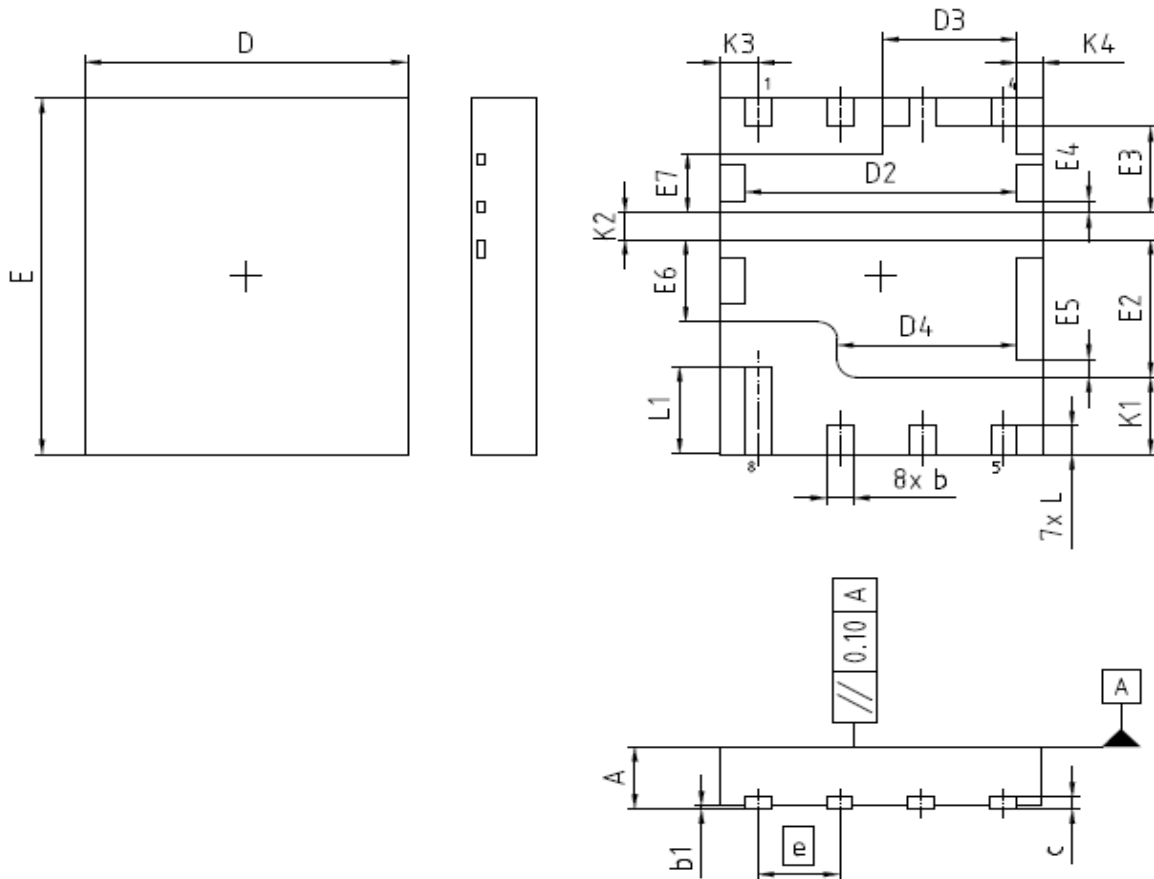
$I_{DSS}=f(V_{DS}); V_{GS}=0\text{ V}$

parameter:  $T_j$



Package Outline

PG-TISON8-4



| DIM | MILLIMETERS |      | INCHES     |       |
|-----|-------------|------|------------|-------|
|     | MIN         | MAX  | MIN        | MAX   |
| A   | 0.90        | 1.15 | 0.035      | 0.045 |
| b   | 0.31        | 0.51 | 0.012      | 0.020 |
| b1  | 0.00        | 0.05 | 0.000      | 0.002 |
| c   | 0.10        | 0.30 | 0.004      | 0.012 |
| D   | 4.90        | 5.10 | 0.193      | 0.201 |
| D2  | 4.12        | 4.32 | 0.162      | 0.170 |
| D3  | 1.99        | 2.19 | 0.078      | 0.086 |
| D4  | 2.69        | 2.89 | 0.106      | 0.114 |
| E   | 5.90        | 6.10 | 0.232      | 0.240 |
| E2  | 2.22        | 2.42 | 0.087      | 0.095 |
| E3  | 1.35        | 1.55 | 0.053      | 0.061 |
| E4  | 0.10        | 0.30 | 0.004      | 0.012 |
| E5  | 0.20        | 0.40 | 0.008      | 0.016 |
| E6  | 1.29        | 1.49 | 0.051      | 0.059 |
| E7  | 0.90        | 1.10 | 0.035      | 0.043 |
| e   | 1.27 (BSC)  |      | 0.05 (BSC) |       |
| N   | 8           |      | 8          |       |
| L   | 0.38        | 0.58 | 0.015      | 0.023 |
| L1  | 1.38        | 1.58 | 0.054      | 0.062 |
| K1  | 1.20        | 1.40 | 0.047      | 0.055 |
| K2  | 0.35        | 0.55 | 0.014      | 0.022 |
| K3  | 0.50        | 0.70 | 0.020      | 0.028 |
| K4  | 0.29        | 0.49 | 0.011      | 0.019 |

DOCUMENT NO.  
28 B00176527

SCALE

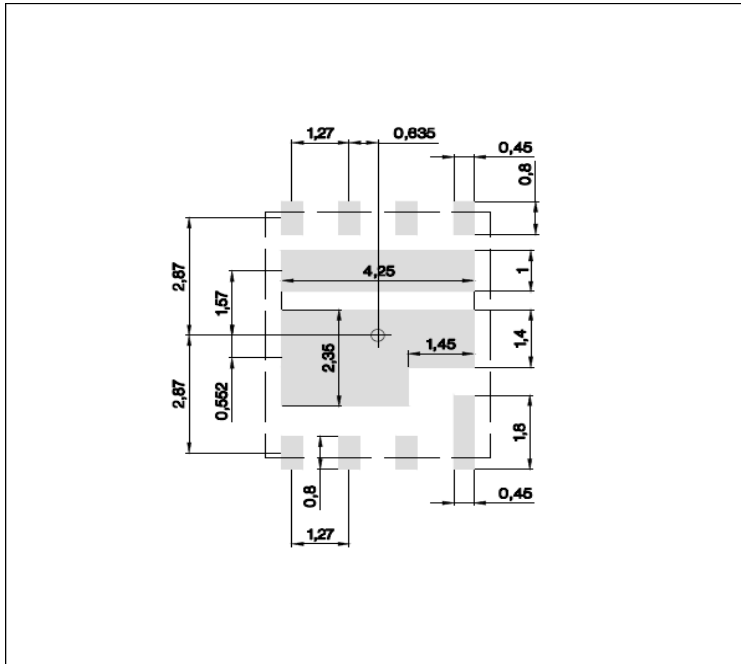
EUROPEAN PROJECTION

ISSUE DATE  
13-03-2015

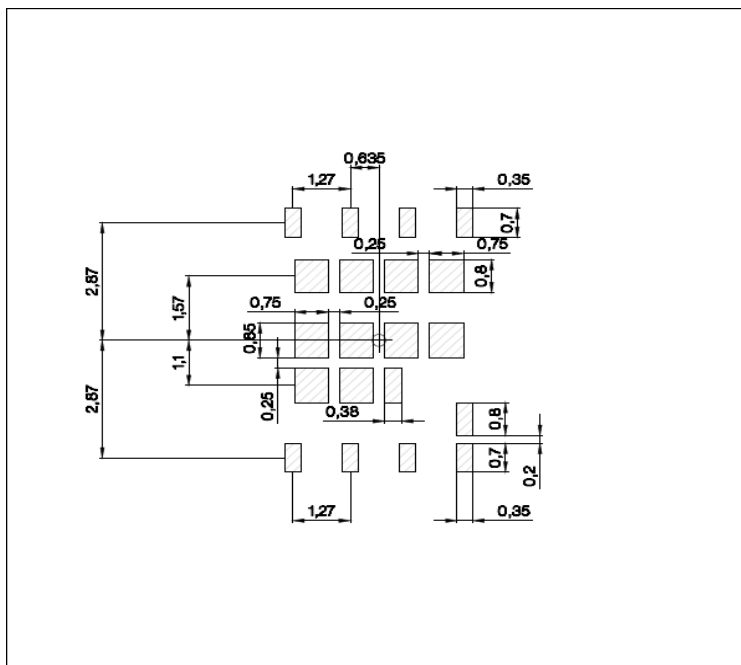
REVISION  
01

Boardpads & Apertures

PG-TISON8-4



■ copper



▨ stencil apertures

All the dimensions in mm

## Revision History

BSG0810NDI

**Revision: 2016-03-24, Rev. 2.1**

Previous Revision

| Revision | Date       | Subjects (major changes since last revision) |
|----------|------------|--|
| 2.0      | 2015-11-11 | Release of final version                     |
| 2.1      | 2016-03-24 | Update package drawing                       |

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